

ZXTN19020DG 20V NPN high gain transistor in SOT223

Summary

 $BV_{CEX} > 70V$

 $BV_{CEO} > 20V$

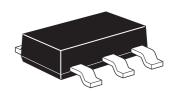
 $BV_{ECO} > 4.5V$

 $I_{C(cont)} = 9A$

V_{CE(sat)} < 35mV @ 1A

 $R_{CE(sat)} = 20m\Omega$

 $P_{D} = 3.0W$



Complementary part number ZXTP19020DG

Description

Packaged in the SOT223 outline this new low saturation NPN transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions.

Features

- Higher power dissipation SOT223 package
- · High gain
- · High peak current
- Low saturation voltage
- · 70V forward blocking voltage
- · 4.5V reverse blocking voltage

Applications

- · DC DC converters
- Motor drive
- · Relay, lamp and solenoid drive
- · Regulator circuits

Ordering information Device Reel size Tape width

DeviceReel size (inches)Tape width (mm)Quantity per reelZXTN19020DGTA7121000

E D C

Pinout - top view

Device marking

ZXTN19020D

Absolute maximum ratings

Parameter	Symbol	Limit	Unit	
Collector-Base voltage	V _{CBO}	70	V	
Collector-Emitter voltage (forward blocking)	V _{CEX}	70	V	
Collector-Emitter voltage	V _{CEO}	20	V	
Emitter-Collector voltage (reverse blocking)	V _{ECX}	6	V	
Emitter-Base voltage	V _{EBO}	7	V	
Continuous Collector current ^(c)	Ic	9	Α	
Base current	I _B	1	Α	
Peak pulse current	I _{CM}	20	Α	
Power dissipation at T _A =25°C ^(a)	P _D	1.2	W	
Linear derating factor		9.6	mW/°C	
Power dissipation at T _A =25°C ^(b)	P _D	1.6	W	
Linear derating factor		12.8	mW/°C	
Power dissipation at T _A =25°C ^(c)	P _D	3.0	W	
Linear derating factor		24	mW/°C	
Power dissipation at T _A =25°C ^(d)	P _D	5.3	W	
Linear derating factor		42	mW/°C	
Power dissipation at T _C =25°C ^(e)	P _D	9.4	W	
Linear derating factor		75	mW/°C	
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C	

Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient ^(a)	$R_{\Theta JA}$	104	°C/W
Junction to ambient ^(b)	$R_{\Theta JA}$	78	°C/W
Junction to ambient ^(c)	$R_{\Theta JA}$	42	°C/W
Junction to ambient ^(d)	$R_{\Theta JA}$	23.5	°C/W
Junction to case ^(e)	$R_{\Theta JC}$	12.3	°C/W

NOTES:

⁽a) For a device surface mounted on 15mm x 15mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

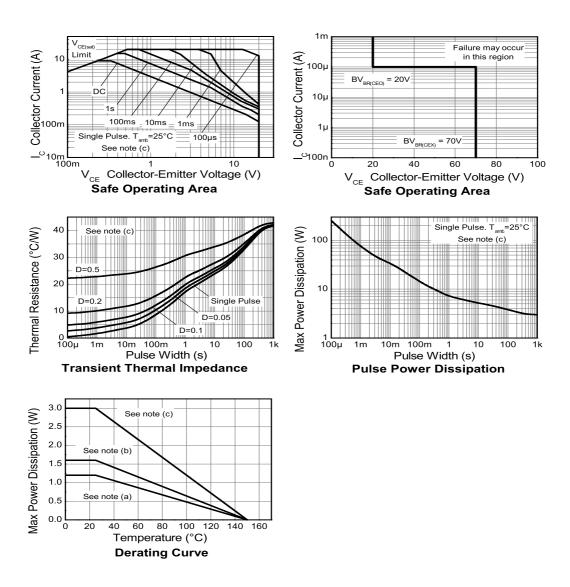
⁽b) Mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

⁽c) Mounted on 50mm x 50mm x 0.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.

⁽d) As (c) above measured at t<5 seconds.

⁽e) Junction to case (collector tab). Typical

Thermal characteristics



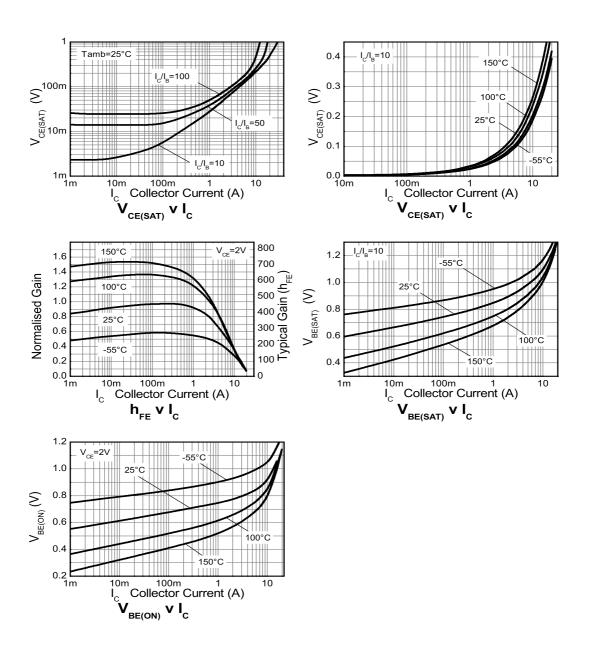
Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated).

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-Base breakdown	BV _{CBO}	70	100		V	$I_C = 100 \mu A$
voltage Collector-Emitter	BV _{CEX}	70	100		V	I_C = 100μA, R_{BF} < 1k Ω
breakdown voltage	D CEX	70	100		V	$C = 100\mu A, \text{ MBE} < 1822$
(forward blocking)						-1V < V _{BE} < 0.25V
Collector-Emitter	BV _{CEO}	20	30		V	I _C = 10mA ^(*)
breakdown voltage					.,	
Emitter-Collector breakdown voltage	BV _{ECX}	6	8.4		V	$I_E = 100 \mu A$, $R_{BC} < 1 kΩ$
(reverse blocking)						or 0.25V > V _{BC} > -0.25V
Emitter-Collector	BV _{ECO}	4.5	5.7		V	$I_F = 100 \mu A$
breakdown voltage	- 1200				-	- Ε 100 μα 1
(reverse blocking)						
Emitter-Base breakdown voltage	BV _{EBO}	7	8.4		V	$I_E = 100 \mu A$
Collector-Base cut-off	I _{CBO}		<1	50	nA	V _{CB} = 70V
current				0.5	μΑ	$V_{CB} = 70V, T_{amb} = 100^{\circ}C$
Collector-Emitter cut-off	I _{CEX}			100	nA	$V_{CE} = 70V$, $R_{BE} < 1k\Omega$ or
current					_	-1V < V _{BE} < 0.25V
Emitter cut-off current	I _{EBO}		<1	50	nA	V _{EB} = 5.6V
Collector-Emitter	V _{CE(sat)}		27	35	mV	$I_C = 1A$, $I_B = 100 \text{mA}^{(*)}$
saturation voltage			50	70	mV	$I_C = 1A$, $I_B = 10mA^{(*)}$
			80	100	mV	$I_C = 2A$, $I_B = 20mA^{(*)}$
			63	80	mV	$I_C = 2A$, $I_B = 40mA^{(*)}$
			85	110	mV	I _C = 4A, I _B = 400mA ^(*) I _C = 9A, I _B = 450mA ^(*)
Base-Emitter saturation	1/		200 1040	250 1150	mV mV	
voltage	V _{BE(sat)}					$I_C = 9A$, $I_B = 450mA^{(*)}$
Base-Emitter turn-on voltage	V _{BE(on)}		910	1050	mV	$I_C = 9A, V_{CE} = 2V^{(*)}$
Static forward current	h _{FE}	300	450	900		$I_C = 100 \text{mA}, V_{CE} = 2V^{(*)}$
transfer ratio		260	390			$I_C = 2A, V_{CE} = 2V^{(*)}$
		130	175			$I_C = 9A, V_{CE} = 2V^{(*)}$
		50	75			$I_C = 15A, V_{CE} = 2V^{(*)}$
			30			$I_C = 20A, V_{CE} = 2V^{(*)}$
Transition frequency	f _T		160		MHz	$I_C = 50 \text{mA}, V_{CE} = 10V$ f = 100MHz
Input capacitance	C _{ibo}		297	400	pF	V _{EB} = 0.5V, f = 1MHz ^(*)
Output capacitance	C _{obo}		32.6	40	pF	V _{CB} = 10V, f = 1MHz ^(*)
Delay time	t _d		129		ns	
Rise time	t _r		96		ns	$I_C = 1A, V_{CC} = 10V,$
Storage time	t _s		398		ns	$I_{B1} = -I_{B2} = 10 \text{mA}$
Fall time	t _f		90		ns	

NOTES:

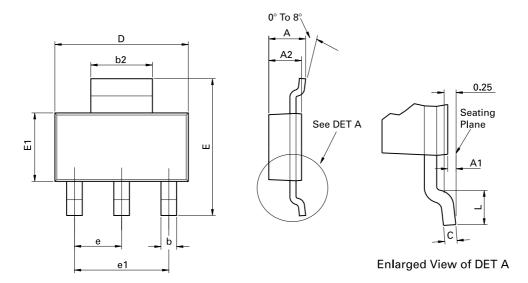
(*) Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2%.

Typical characteristics



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Package outline - SOT223



Conforms to JEDEC TO-261 AA Issue B

Dim.	Millimeters		Inches		Dim.	Millin	neters	Inc	hes
	Min.	Max.	Min.	Max.	D IIII.	Min.	Max.	Min.	Max.
Α	-	1.80	-	0.071	D	6.30	6.70	0.248	0.264
A1	0.02	0.10	0.0008	0.004	е	2.30 BSC		0.0905 BSC	
A2	1.55	1.65	0.0610	0.0649	e1	4.60 BSC		0.181 BSC	
b	0.66	0.84	0.026	0.033	E	6.70	7.30	0.264	0.287
b2	2.90	3.10	0.114	0.122	E1	3.30	3.70	0.130	0.146
С	0.23	0.33	0.009	0.013	L	0.90	-	0.355	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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